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Soundness and completeness of quantum root-mean-square errors

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Classical Root-Mean-Square Error

• Definition. If a quantity A is indirectly measured by measuring another quantity M with the joint probability distribution $\mu(a, m)$ of A and M, the root-mean-square error $\varepsilon_G(\mu)$ of the measurement of A is defined by

$$arepsilon_G(\mu) = \left(\sum_{a,m} (m-a)^2 \mu(a,m)
ight)^{1/2}$$
 .

ullet Theorem. $arepsilon_G(\mu)=0$ if and only if $\mu\{M=A\}=1$, where

$$\mu\{M=A\} = \sum_{(a,m):m=a} \mu(a,m).$$

Universal Models for Quantum Measurements

• Definition. $\mathbf{M}=(\mathcal{K},\xi,U,M)$: Measuring Process for the system described by $\mathcal{H}\Leftrightarrow$

 \mathcal{K} = a Hilbert space, modeling the state space of the probe

 ξ = a unit vector on K, modeling the initial state of the probe

U =a unitary on $\mathcal{H} \otimes \mathcal{K}$, modeling the measuring interaction

 $M = \text{a self-adjoint operator on } \mathcal{K}, \text{modeling the meter observable}$

• For any $A,B\in \mathcal{O}(\mathcal{H}),$ the measuring process M from time 0 to τ determines

$$A(0)=A\otimes I, \quad B(0)=B\otimes I, \quad M(0)=I\otimes M, \ A(au)=U^\dagger A(0)U, \quad B(au)=U^\dagger B(0)U, \quad M(au)=U^\dagger M(0)U.$$

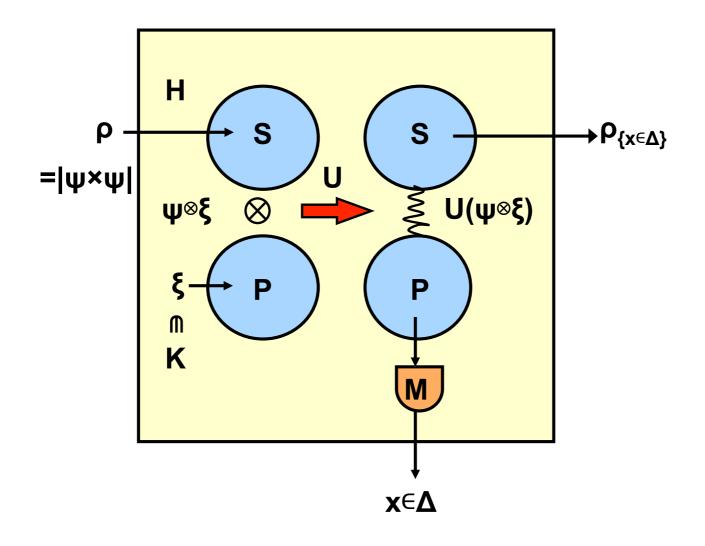


Figure 1: Measuring Preocess

• When is the measurement $M=(\mathcal{K},\xi,U,M)$ of A in ψ considered accurate? —The joint probability distribution μ of $M(\tau),A(0)$ exists and satisfies $\mu\{M(\tau)=A(0)\}=1$.

State-Dependent Commutativity

- Definition: X and Y commute in Ψ ($X \leftrightarrow_{\Psi} Y$) iff $[f(X), g(Y)]\Psi = 0$ for all polynomials f(X), g(Y).
- Definition: A joint probability distribution (JPD) of observables X,Y in state Ψ is a probability distribution $\mu_{\Psi}^{X,Y}(x,y)$ on \mathbf{R}^2 satisfying

$$\langle \Psi | f(X,Y) | \Psi
angle = \sum_{x,y} f(x,y) \, \mu_{\Psi}^{X,Y}(x,y)$$

for any polynomial f(X, Y).

• Theorem: There exists a JPD of A, B in Ψ .

$$\Leftrightarrow A \leftrightarrow_{\Psi} B$$

 $\Leftrightarrow \Psi$ is a superposition of common eigenstates of A and B, i.e.,

$$\Psi = \sum_{x,y} c_{x,y} \ket{A=x,B=y}$$
 .

Weak Joint Distribution

ullet Definition: The weak joint distribution (WJD) $u_{\Psi}^{A,B}(x,y)$ of observables A,B in state Ψ is defined by

$$u_{\Psi}^{A,B}(x,y) = \left\langle \Psi | P^A(x) P^B(y) | \Psi
ight
angle .$$

• Remark: The WJD can be measured by weak measurement and post-selection, i.e.,

$$u_{\Psi}^{A,B}(x,y) = \left\langle P^B(y)
ight
angle_{w,A=x,\Psi} \mu_{\Psi}^A(x).$$

Quantum Perfect Correlation

• Definition: A and B are perfectly correlated in Ψ $(A =_{\Psi} B)$ $\Leftrightarrow A \leftrightarrow_{\Psi} B$ and the JPD $\mu_{\Psi}^{A,B}$ satisfies

$$\sum_x \mu_{\Psi}^{A,B}(x,x) = 1.$$

• Theorem (MO 2005):

$$egin{aligned} A =_\Psi B &\Leftrightarrow&
u_\Psi^{A,B}(x,y) = 0 & ext{if } x
eq y \ &\Leftrightarrow& \left\langle P^B(y)
ight
angle_{w,A=x,\Psi} = \delta_{x,y}. \end{aligned}$$

- Remark: Perfect correlation is experimentally accessible.
- Theorem (MO 2005): The relation $=_{\Psi}$ is an equivalence relation among observables. In particular, if $A =_{\Psi} B$ and $B =_{\Psi} C$, then $A =_{\Psi} C$.

State-Dependent Accurate Measurements

• Definition (MO 2005): A measuring process $\mathbf{M}=(\mathcal{K},\xi,U,M)$ accurately measures A in $\psi\Leftrightarrow$

$$A(0) =_{\psi \otimes \xi} M(au).$$

• Remark: The above condition is operationally accessible, since it is equivalent to

$$\sum_{x
eq y} |
u_{\psi \otimes \xi}^{A(0),M(au)}(x,y)| = 0.$$

ullet Theorem A measuring process $\mathbf{M}=(\mathcal{K},\xi,U,M)$ accurately measures A in $\psi\Leftrightarrow$

$$\psi \otimes \xi = \sum_x c_x |A(0) = x, M(au) = x \rangle,$$

where $|c_x|^2=|\left<\psi|A=x\right>|^2$.

Noise Operator based Quantum Root-Mean-Square Error

ullet Definition. For any measuring process $\mathbf{M}=(\mathcal{K},\xi,U,M)$ the noise operator N(A) for measuring A is defined by

$$N(A) = M(\tau) - A(0).$$

• The NO based QRMSE for measuring A in Ψ is defined by

$$arepsilon_{NO}(A,\psi) = \left\langle N(A)^2
ight
angle^{1/2} = \|[M(au) - A(0)]\psi \otimes \xi\|.$$

ullet Theorem (Lund-Wiseman 2010) The NO based QRMSE $arepsilon_{NO}(A,\psi)$ can be measured by weak measurement and post-selection

$$\varepsilon_{NO}(A,\psi)^2 = \sum_{a,m} (m-a)^2 \operatorname{Re} \nu_{\psi \otimes \xi}^{\mathrm{M}(\tau),\mathrm{A}(0)}(\mathrm{m,a}).$$

Requirements for Quantum RMS Errors

- (i) Device-independent definability: The error measure should be definable by the POVM of the measuring process, the observable to be measured, and the state of the object.
- (ii) Correspondence principle: The error measure should be identical with the classical rms error if the joint probability distribution of $M(\tau)$ and A(0) exists.
- (iii) Soundness: The error measure should take the value zero for any accurate measurements.
- (iv) Completeness: The error measure should take the value zero if and only if the measurement is accurate.

Device-Independent Definability

- The NO based QRMSE ε_{NO} , satisfies the device-independent definability.
- ullet The POVM of M: $\Pi(x) = \left\langle \xi | E^{M(au)}(x) | \xi
 ight
 angle$
- Moment operator of POVM Π : $m^{(n)}(\Pi) = \sum_{x \in \mathbb{R}} x^n \Pi(x)$
- $\varepsilon_{NO}(A,\psi)$ satisfies

$$arepsilon_{NO}(A,\psi)^2 = \mathrm{Re} \left\langle \psi | \mathrm{m}^{(2)}(\Pi) - 2 \mathrm{m}(\Pi) \mathrm{A} + \mathrm{A}^2 | \psi
ight
angle.$$

Correspondence Principle

- The NO based QRMSE ε_{NO} satisfies the correspondence principle.
- If $M(\tau)$ and A(0) commute in $\psi \otimes \xi$, there exists the joint probability distribution $\mu(a,m)=\mu_{\psi\otimes\xi}^{A(0),M(\tau)}(a,m)$ and we have

$$arepsilon_{NO}(A,\psi)^2 = \sum_{a,m} (m-a)^2 \mu(a,m).$$

 Note that any error notions having been proposed based on the distance between the probability distributions do not satisfy the Correspondence Principle.

Soundness

- The NO based QRMSE ε_{NO} satisfies the soundness condition.
- If $A(0) =_{\Psi \otimes \sigma} M(\tau)$ then

$$\mu^{M(au),A(0)}_{\psi\otimes oldsymbol{\xi}}(m,a)=0 \quad ext{for } m
eq a,$$

and hence

$$arepsilon_{NO}(A,\psi)^2 = \sum_{a,m} (m-a)^2 \mu_{\psi}^{M(au),A(0)}(m,a) = 0.$$

• The NO based QRMSE satisfies the device-independent-definability, the correspondence principle, and the soundness.

Locally Uniform Quantum Root Mean Square Error

• For any $t \in \mathbb{R}$, define

$$\varepsilon_t(A, \psi) = \varepsilon_{NO}(A, e^{-itA}\psi).$$

• The locally uniform rms error is defined by

$$\overline{\varepsilon}(A,\psi) = \sup_{t \in \mathbb{R}} \varepsilon_t(A,\psi).$$

• Theorem: (1) If A(0) and $M(\tau)$ commute in $\psi \otimes \xi$, then

$$\overline{\varepsilon}(A,\psi) = \varepsilon_{NO}(A,\psi).$$

- (2) $\overline{\varepsilon}$ satisfies all the requirements (i)–(iv).
- $(3) \, \varepsilon_{NO}(A, \psi) \leq \overline{\varepsilon}(A, \psi).$
- (4) If $A(0)^2=M(au)^2=I$, then $\overline{arepsilon}(A,\psi)=arepsilon_{NO}(A,\psi)$.
- (5) The relation

$$\overline{arepsilon}(Q,\psi)\overline{arepsilon}(P,\psi)\geqrac{\hbar}{2}$$

is violated.

Example

$$A=\left[egin{array}{cc} 1 & 1 \ 1 & 1 \end{array}
ight],\, M=\left[egin{array}{cc} 1 & 1 \ 1 & -1 \end{array}
ight],\, \ket{\psi}=\left[egin{array}{cc} 1 \ 0 \end{array}
ight]$$

with $\Pi(y) = P^M(y)$. Then we have

$$\varepsilon_{NO}(A,\Pi,\psi)=0,$$

but the measurement is not accurate, since A and Π are not identically distributed as $\left\langle \psi | P^A(2) | \psi \right\rangle = 1/2$ but $\left\langle \psi | \Pi(2) | \psi \right\rangle = 0$.

We have

$$\varepsilon_t(A, \Pi, \psi) = 2|\sin t|, \quad \text{and} \quad \overline{\varepsilon}(A, \Pi, \psi) = 2,$$
 (1)

despite of the relation $\varepsilon_{NO}(A,\Pi,\psi)=0$, the relation $\overline{\varepsilon}(A,\Pi,\psi)=2$ correctly indicate that the above measurement of A is not accurate.

Simultaneous Measurements

- ullet Let $\mathrm{M}=(\mathcal{K},\xi,U,M)$ be a measuring process. For any function f define $f(\mathrm{M})=(\mathcal{K},\xi,U,f(M))$
- Definition. A simultaneous measurement for A,B in Ψ is is defined as a pair of measuring processes (f(M),g(M)).
- ullet Definition: A simultaneous measurement $(f(\mathbf{M}),g(\mathbf{M}))$ for A,B in ξ is accurate iff

$$f(M(au)) =_{\Psi \otimes \xi} A(0),$$

$$g(M(au)) =_{\Psi \otimes \xi} B(0).$$

Uncertainty Relations for Simultaneous Measurements

- Definition. The error $(\overline{\varepsilon}(A), \overline{\varepsilon}(B))$ of a simultaneous measurement $(f(\mathrm{M}), g(\mathrm{M}))$ for A, B in ξ is defined by $\overline{\varepsilon}(A) = \overline{\varepsilon}(A, \psi, f(\mathrm{M}))$ and $\overline{\varepsilon}(B) = \overline{\varepsilon}(B, \psi, g(\mathrm{M}))$.
- Theorem. (f(M), g(M)) is accurate if and only if $(\overline{\varepsilon}(A), \overline{\varepsilon}(B)) = (0, 0)$.
- ullet Theorem. Let $C_{AB}=rac{1}{2}|raket{\psi|[A,B]|\psi}|.$ The following relations hold

$$(\mathbf{i})\,\overline{\varepsilon}(A)\overline{\varepsilon}(B)+\sigma(B)\overline{\varepsilon}(A)+\sigma(A)\overline{\varepsilon}(B)\geq C_{AB}.$$

$$\begin{array}{l} \text{(ii) } \sigma(B)^2\overline{\varepsilon}(A)^2 + \sigma(A)^2\overline{\varepsilon}(B)^2 \\ +2\overline{\varepsilon}(A)\overline{\varepsilon}(B)\sqrt{\sigma(A)^2\sigma(B)^2 - C_{AB}^2} \geq C_{AB}^2. \end{array}$$